

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/701,452	HAYASHI ET AL.	
Examiner	Art Unit	
Lenard A. Footland	3682	

	SEARCHED				
Class	Subclass	Date	Examiner		
384	623				
	621				
<u> </u>	614				
	571				
	619	•'			
	•	7-19-05	M		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
_			
	<u> </u>		

SEARCH NO (INCLUDING SEARCH	IES ISTRATEGY	')
	DATE	EXMR
		:
·		
	:	